



VEC2601 — N-Channel and P-Channel Silicon MOSFETs

General-Purpose Switching Device Applications

Features

- A composite type of a low on-resistance P-channel MOSFET and a small signal N-channel MOSFET for driving P-channel MOSFET enables high-density mounting.
- Best suited for load switches.
- 2.5V drive.
- 0.75mm mount high.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	N-channel	P-channel	Unit
Drain-to-Source Voltage	V _{DSS}		30	-20	V
Gate-to-Source Voltage	V _{GSS}		±10	±10	V
Drain Current (DC)	I _D		0.15	-3	A
Drain Current (Pulse)	I _{DP}	PW≤10μs, duty cycle≤1%	0.6	-12	A
Allowable Power Dissipation	P _D	Mounted on a ceramic board (90mm ² X0.8mm)1unit	0.9		W
Channel Temperature	T _{ch}		150		°C
Storage Temperature	T _{stg}		-55 to +150		°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
[N-channel]						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	I _D =1mA, V _{GS} =0V	30			V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V, V _{GS} =0V			1	μA
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} =±8V, V _{DS} =0V			±10	μA
Cutoff Voltage	V _{GS(off)}	V _{DS} =10V, I _D =100μA	0.4		1.3	V
Forward Transfer Admittance	y _{fs}	V _{DS} =10V, I _D =80mA	0.15	0.22		S

Marking : BD

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VEC2601

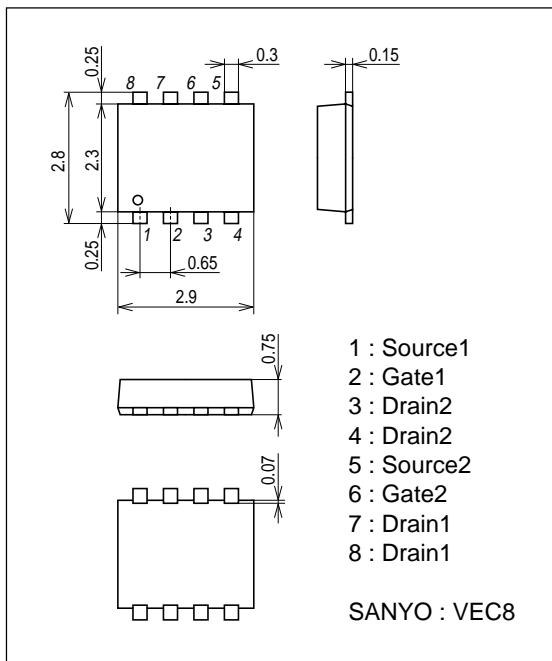
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Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Static Drain-to-Source On-State Resistance	R _{DS(on)1}	I _D =80mA, V _{GS} =4V		2.9	3.7	Ω
	R _{DS(on)2}	I _D =40mA, V _{GS} =2.5V		3.7	5.2	Ω
	R _{DS(on)3}	I _D =10mA, V _{GS} =1.5V		6.4	12.8	Ω
Input Capacitance	C _{iss}	V _{DS} =10V, f=1MHz		7.0		pF
Output Capacitance	C _{oss}	V _{DS} =10V, f=1MHz		5.9		pF
Reverse Transfer Capacitance	C _{rss}	V _{DS} =10V, f=1MHz		2.3		pF
Turn-ON Delay Time	t _{d(on)}	See specified Test Circuit.		19		ns
Rise Time	t _r	See specified Test Circuit.		65		ns
Turn-OFF Delay Time	t _{d(off)}	See specified Test Circuit.		155		ns
Fall Time	t _f	See specified Test Circuit.		120		ns
Total Gate Charge	Q _g	V _{DS} =10V, V _{GS} =10V, I _D =150mA		1.58		nC
Gate-to-Source Charge	Q _{gs}	V _{DS} =10V, V _{GS} =10V, I _D =150mA		0.26		nC
Gate-to-Drain "Miller" Charge	Q _{gd}	V _{DS} =10V, V _{GS} =10V, I _D =150mA		0.31		nC
Diode Forward Voltage	V _{SD}	I _S =150mA, V _{GS} =0V		0.87	1.2	V
[P-channel]						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	I _D =-1mA, V _{GS} =0V	-20			V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} =-20V, V _{GS} =0V			-1	μA
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} =±8V, V _{DS} =0V			±10	μA
Cutoff Voltage	V _{GS(off)}	V _{DS} =-10V, I _D =-1mA	-0.4		-1.3	V
Forward Transfer Admittance	y _{fs}	V _{DS} =-10V, I _D =-1.5A	2.9	4.9		S
Static Drain-to-Source On-State Resistance	R _{DS(on)1}	I _D =-2A, V _{GS} =-4.5V		55	72	mΩ
	R _{DS(on)2}	I _D =-1A, V _{GS} =-2.5V		77	108	mΩ
	R _{DS(on)3}	I _D =-0.3A, V _{GS} =-1.8V		112	168	mΩ
Input Capacitance	C _{iss}	V _{DS} =-10V, f=1MHz		680		pF
Output Capacitance	C _{oss}	V _{DS} =-10V, f=1MHz		115		pF
Reverse Transfer Capacitance	C _{rss}	V _{DS} =-10V, f=1MHz		80		pF
Turn-ON Delay Time	t _{d(on)}	See specified Test Circuit.		13		ns
Rise Time	t _r	See specified Test Circuit.		53		ns
Turn-OFF Delay Time	t _{d(off)}	See specified Test Circuit.		77		ns
Fall Time	t _f	See specified Test Circuit.		62		ns
Total Gate Charge	Q _g	V _{DS} =-10V, V _{GS} =-4.5V, I _D =-3A		8.2		nC
Gate-to-Source Charge	Q _{gs}	V _{DS} =-10V, V _{GS} =-4.5V, I _D =-3A		1.7		nC
Gate-to-Drain "Miller" Charge	Q _{gd}	V _{DS} =-10V, V _{GS} =-4.5V, I _D =-3A		2.1		nC
Diode Forward Voltage	V _{SD}	I _S =-3A, V _{GS} =0V		-0.88	-1.2	V

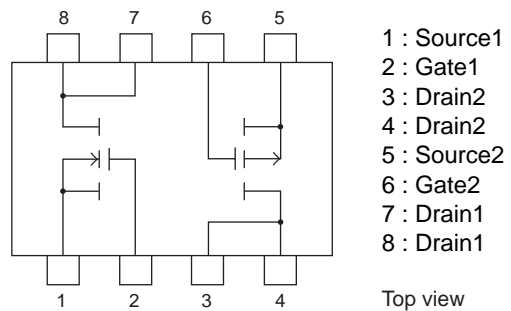
Package Dimensions

unit : mm (typ)

7012-009



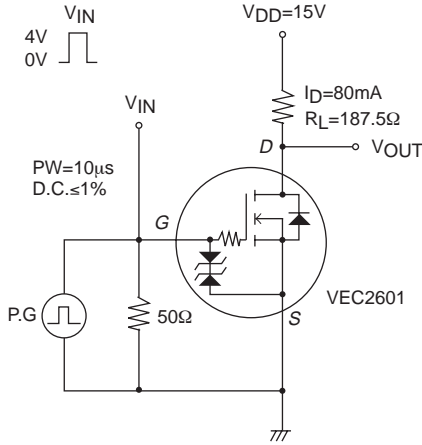
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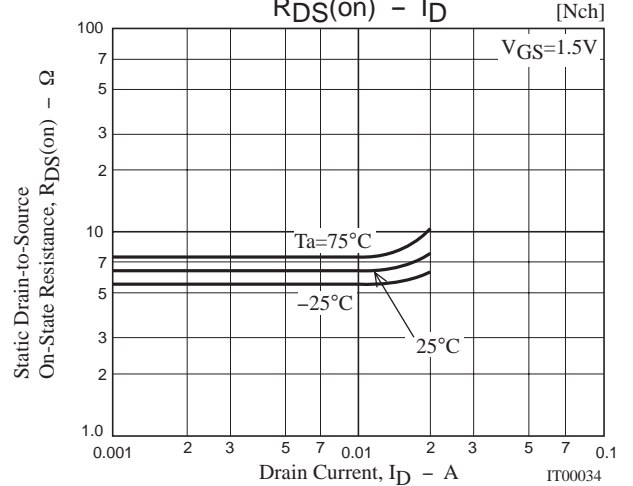
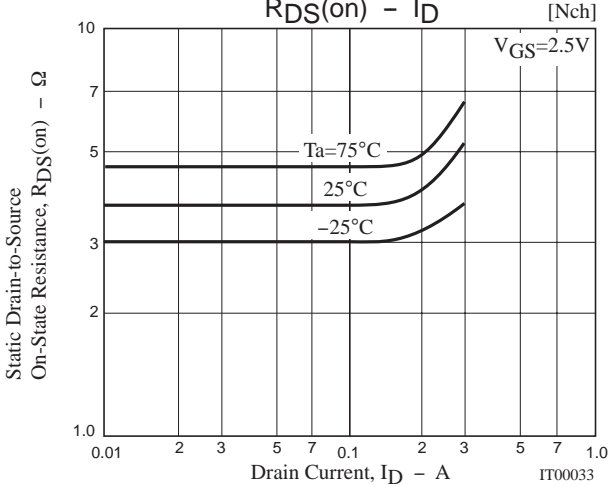
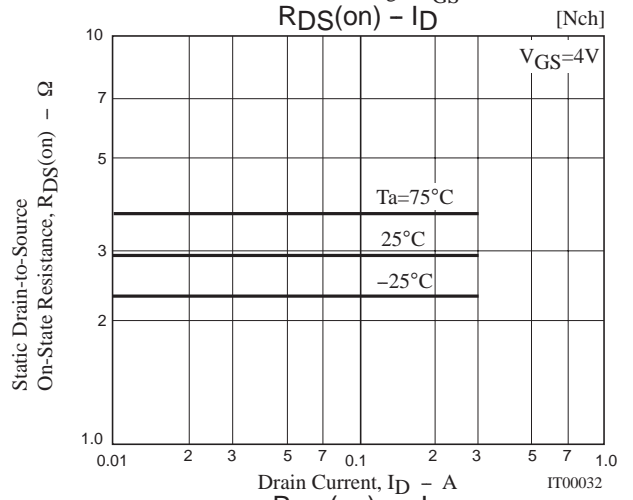
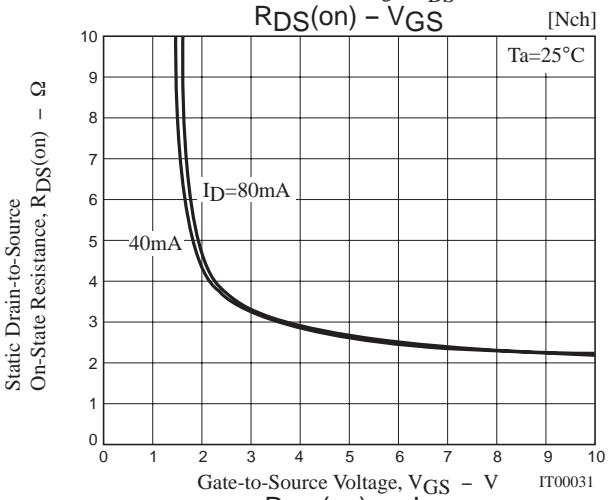
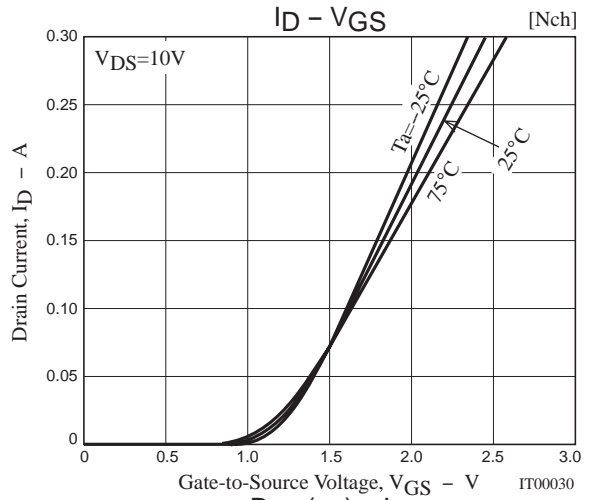
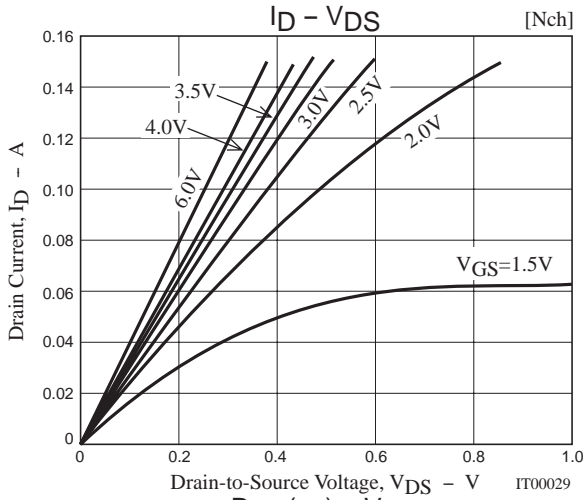
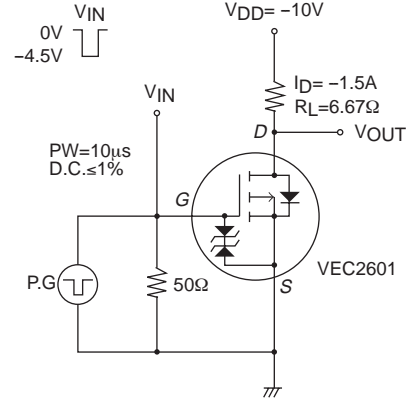
VEC2601

Switching Time Test Circuit

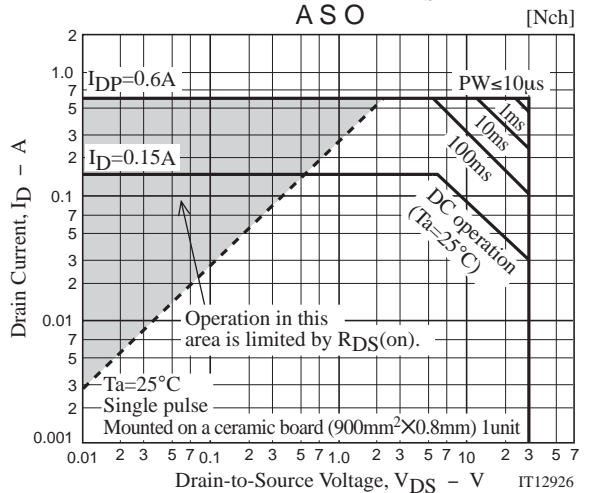
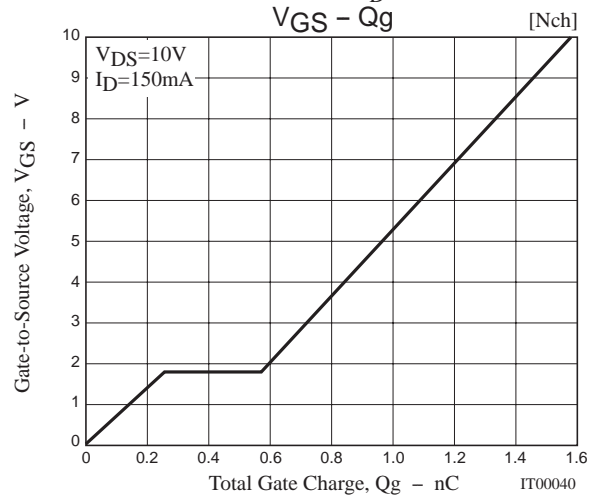
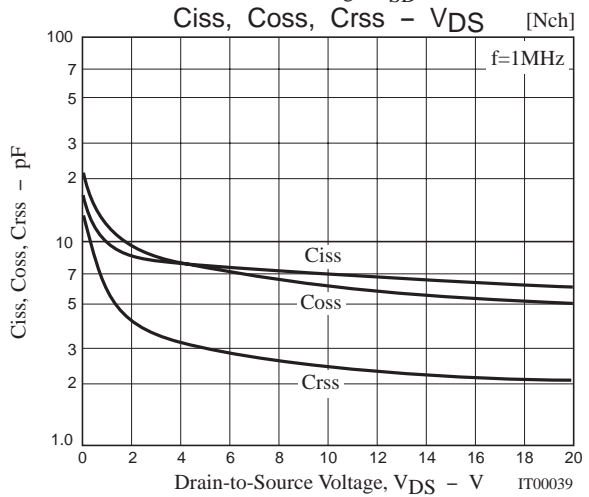
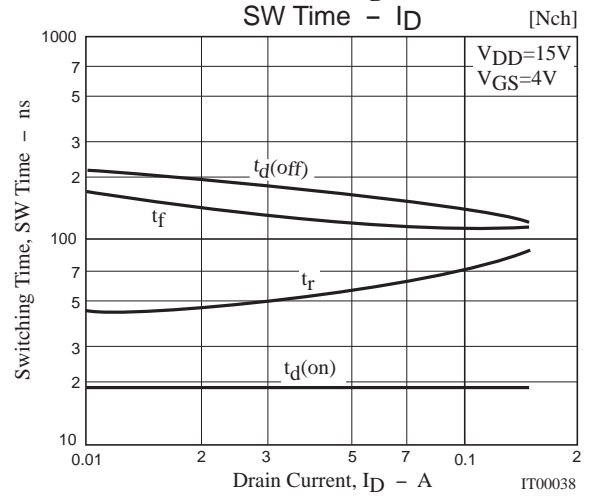
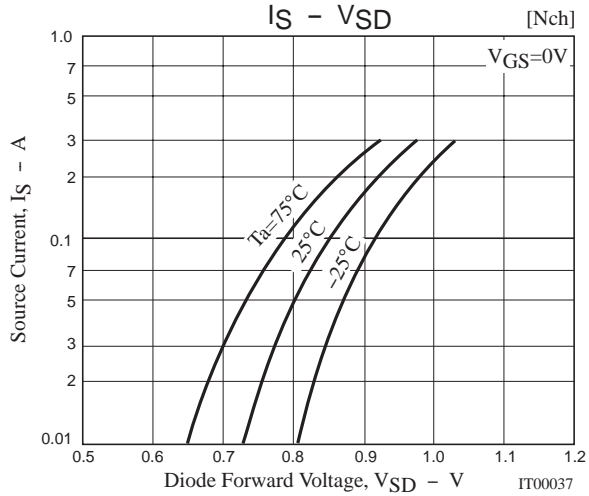
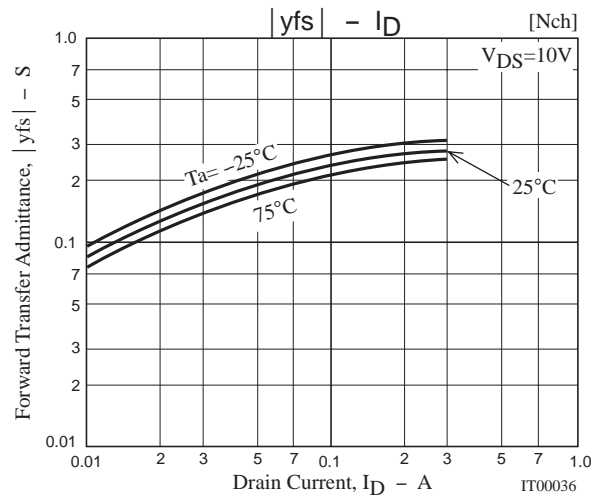
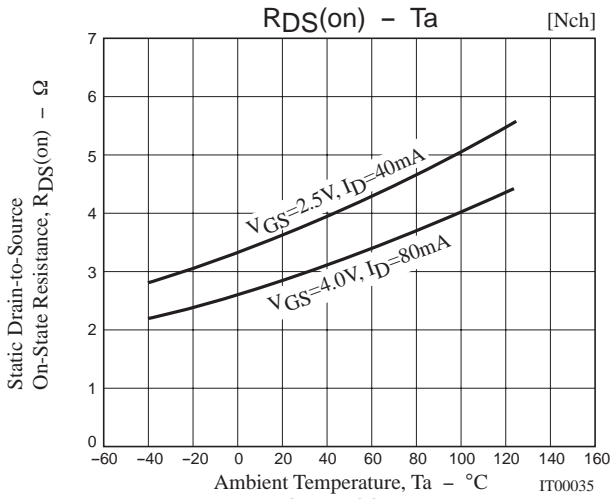
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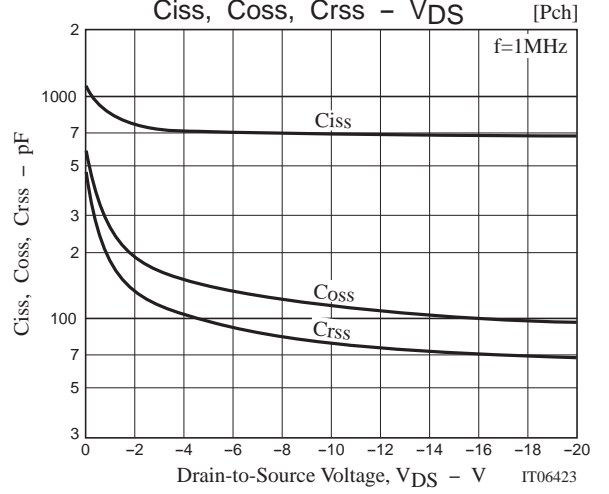
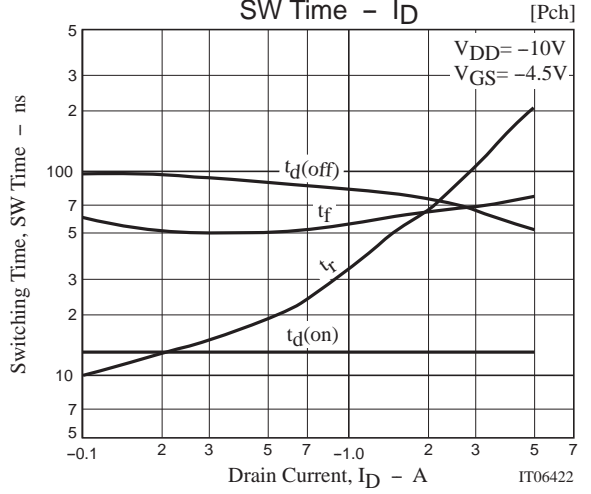
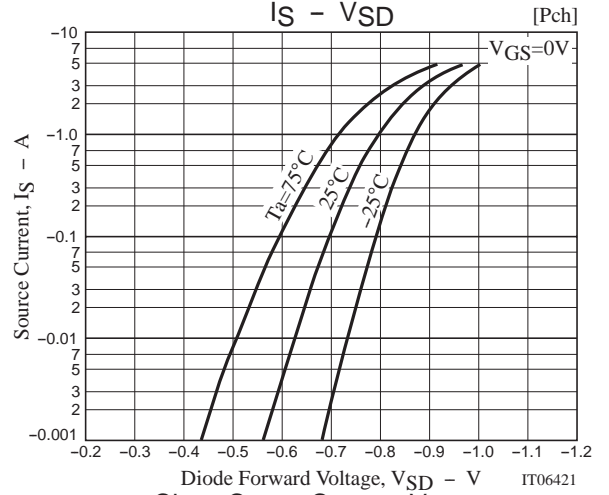
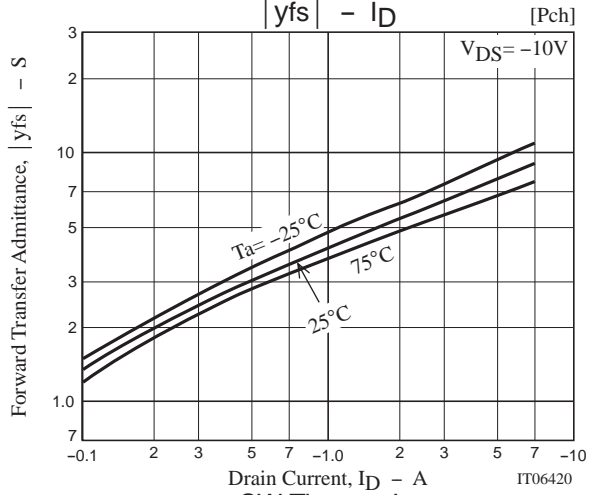
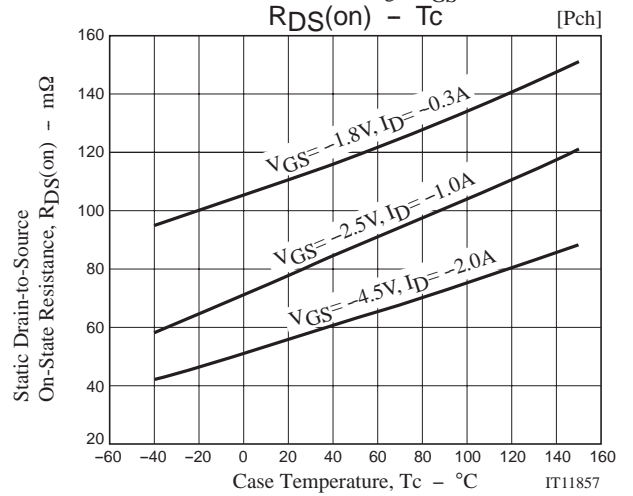
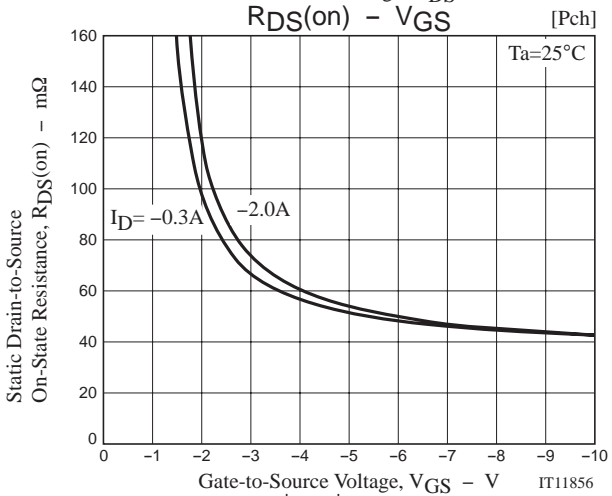
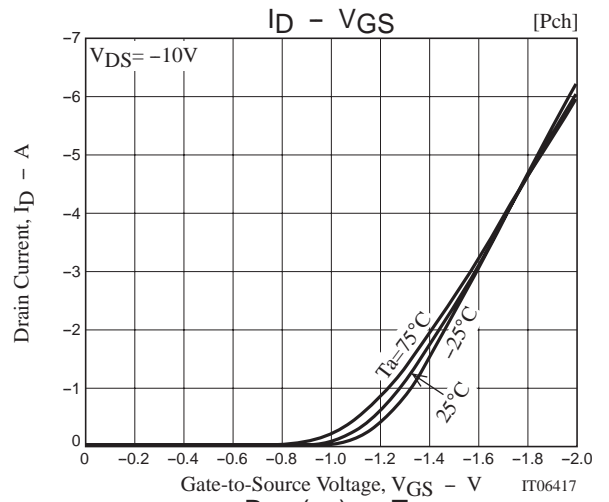
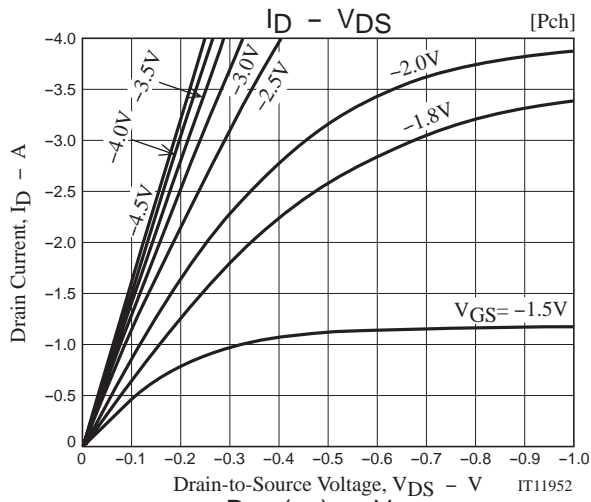
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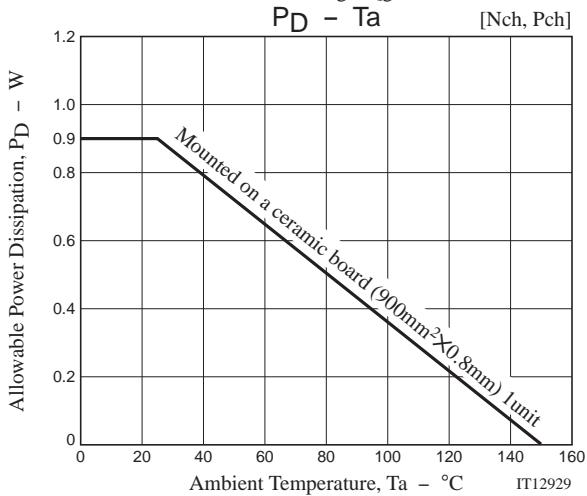
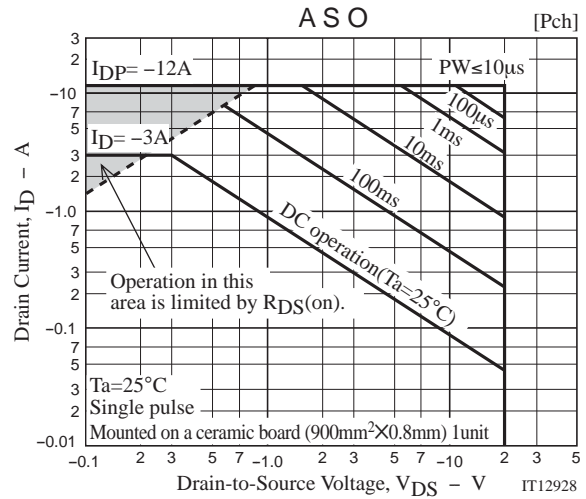
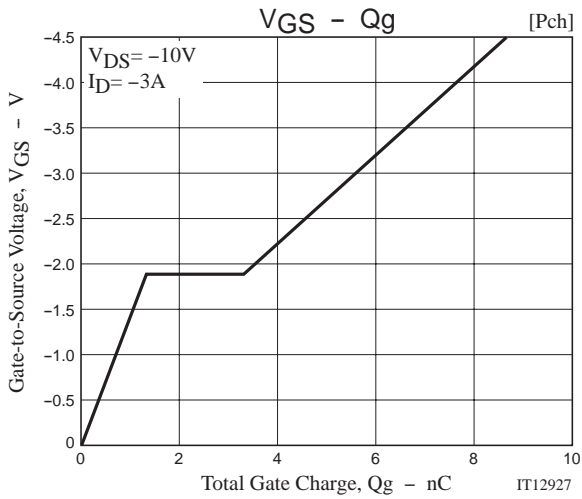


VEC2601



VEC2601





Note on usage : Since the VEC2601 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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